Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination KIM ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| X | Α | US-6,754,371 | 06-2004 | Kondo et al. | 382/107 |
| X | В | US-6,122,017 | 09-2000 | Taubman, David S. | 348/620 |
| X | С | US-6,275,259 | 08-2001 | Gowda et al. | 348/229.1 |
| X | D | US-5,434,627 | 07-1995 | Weston, Martin | 348/609 |
| X | E | US-6,014,182 | 01-2000 | Swartz, Peter D. | 348/700 |
| X | F | US-6,288,745 | 09-2001 | Okuno et al. | 348/448 |
| X | G | US-6,788,823 | 09-2004 | Allred et al. | 382/260 |
| | Н | US- | | | |
| | J | US- | | , | |
| | J | US- | | | |
| | К | US- | | | · |
| | L | US- | | · | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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| | U | |
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| | V | |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.